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A New View of Electrochemistry at Highly Oriented Pyrolytic Graphite (HOPG)

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ABSTRACT Major new insights on electrochemical processes at graphite electrodes are reported, through extensive investigations of two of the most studied redox couples, Fe(CN)$_6^{3+/2+}$ and Ru(NH$_3$)$_6^{3+/2+}$. Experiments have been carried out on 5 different grades of highly orientated pyrolytic graphite (HOPG) that vary in step edge height and surface coverage. Significantly, the same electrochemical characteristic is observed on all surfaces, independent of surface quality: initial cyclic voltammetry (CV) is close to reversible on freshly cleaved surfaces (> 400 measurements for Fe(CN)$_6^{4+/3-}$ and > 100 for Ru(NH$_3$)$_6^{3+/2+}$), in marked contrast to previous studies that have found very slow electron transfer (ET) kinetics, with an interpretation that ET only occurs at step edges. Significantly, high spatial resolution electrochemical imaging with scanning electrochemical cell microscopy (SECCM), on the highest quality mechanically cleaved HOPG, demonstrates definitively that the pristine basal surface supports fast ET, and that ET is not confined to step edges. However, the history of the HOPG surface strongly influences the electrochemical behavior. Thus, Fe(CN)$_6^{4+/3-}$ shows markedly diminished ET kinetics with either extended exposure of the HOPG surface to the ambient environment or repeated CV measurements. In-situ AFM reveals that the deterioration in apparent ET kinetics is coupled with the deposition of material on the HOPG electrode, while conducting-AFM highlights that, after cleaving, the local surface conductivity of HOPG deteriorates significantly with time. These observations and new insights are not only important for graphite, but have significant implications for electrochemistry at related carbon materials such as graphene and carbon nanotubes.
INTRODUCTION

The electrochemical characteristics of highly oriented pyrolytic graphite (HOPG) and related materials are presently attracting considerable attention. In part, this has been driven by a desire to identify similarities and differences in the electrochemistry of HOPG, carbon nanotubes (CNTs), and graphene, which share the same basic sp² carbon structural motif, and are attracting huge interest for electrochemically related applications. Furthermore, knowledge of the intrinsic electrochemical properties of HOPG and graphite impacts our understanding of a diversity of processes, from carbon surface functionalization to (electro)catalysis. Moreover, the basal surface of HOPG has proven popular as an electrode support for investigations of heterogeneous metal nucleation and electrodeposition, for model studies of nanoparticle (NP) electrocatalysts, and the creation of nanostructured interfaces for electrochemistry, sensing and biosensing. In all of these areas, a true understanding of the electrochemistry of the basal surface of HOPG is crucial for the rational design of functionalized interfaces, electrochemical sensors and electrocatalysts.

A large body of work has suggested that the basal surface of HOPG is characterized by rather poor electrode kinetics, compared to edge plane graphite, for a wide range of redox couples, including classical outer sphere and inner sphere couples. Indeed, until recently, the traditional consensus was that the basal surface of HOPG had very low activity or even no electroactivity, with the step edges intersecting the basal surface providing essentially all of the sites for electron transfer (ET) for a range of redox couples. However, even within this body of work there are significant differences in the behavior reported for some redox couples. Furthermore, recent microscopic and nanoscopic studies challenge this model and suggest that the pristine basal surface of HOPG has significant ET activity. As a consequence, and given the prominence of HOPG as an important electrode material, we have undertaken a thorough study of its electrochemical and surface properties (vida infra),
with the aim of providing a coherent view of the field. We deduce that pristine, freshly cleaved HOPG actually has considerable activity as an electrode material, but complex surface effects operate that may alter its behavior. Importantly, we propose a model which is self-consistent from the nanoscale to macroscale and which can be tested directly at this range of length scales.

Claims about the inactivity of basal plane HOPG have, in some cases, led to further speculation about the sites of ET on CNTs and graphene. Specifically, it has been proposed that interfacial ET only occurs at edge-plane like sites in multi-walled CNTs and at the open ends of single-walled and multi-walled CNTs, or at the graphene edge. In contrast, fast (often reversible) electrochemistry is evident in studies of pristine, well-characterized single-walled carbon nanotubes (SWNTs) grown by chemical vapor deposition, and at mechanically exfoliated graphene, suggesting that ET occurs readily at the interface between sp² carbon and electrolyte solution. This provides a further impetus to understand HOPG electrochemistry more fully, not least because SWNT network electrodes and single nanotube devices show unprecedented limits of detection in voltammetric analysis (orders of magnitude better than other common carbon materials and d-metals).

A wide range of peak-to-peak separation (ΔEₚ) values in cyclic voltammetry (CV) measurements of Fe(CN)₆⁴⁻/₃⁻ (typical scan rates at 0.1 V s⁻¹ to 1 V s⁻¹; although occasionally higher) have been found on the cleaved basal surface, in the range 58 mV (essentially reversible) – 1.5 V. This corresponds to effective standard heterogeneous ET rate constants, kₒ (in terms of the net current response for the entire surface), of at least 5 - 8 orders of magnitude, from less than 10⁻⁹ cm s⁻¹ or 10⁻⁶ cm s⁻¹ to > 0.1 cm s⁻¹ (i.e. reversible on the CV time scale under conditions of planar diffusion). By implication, a similar change in the magnitude of surface defect (step) coverage, from one cleave of HOPG to another, would reasonably be expected within the bounds of a step defect-driven model of
HOPG electrode activity. This is not evident based on current knowledge of step-edge density on freshly cleaved HOPG. Indeed, early scanning tunneling microscopy (STM) of the basal surface of HOPG revealed step edge densities in the range of 1-10%, and this appears to be a generally accepted range, with the step edge density depending on the source of HOPG and cleavage method. We provide detailed analysis of this aspect herein. Other approaches for probing HOPG surface quality which have been complemented with CV measurements have included capacitance measurements, complementary microscopy and spectroscopy studies and anthraquinone disulfonate adsorption, which was proposed to serve as an indirect marker of step (defect) density.

Recent advances in electrochemical imaging have facilitated localized investigations of HOPG in defined locations and at high spatial resolution. Such studies allow local electrochemical measurements to be correlated directly with the corresponding surface structure. We recently used scanning electrochemical cell microscopy (SECCM) to investigate the basal surface of HOPG with a spatial resolution an order of magnitude smaller than the characteristic step spacing. Moreover, SECCM allowed the location of the measurements (step edge or basal surface) to be determined unambiguously. We found the ET kinetics for both Fe(CN)$_6^{4-/3-}$ and Ru(NH$_3$)$_6^{3+/2+}$ to be close to reversible ($k_0 > 0.1$ cm s$^{-1}$), although we noted that the Fe(CN)$_6^{4-/3-}$ response diminished significantly with time during the course of recording an image. These studies built on earlier investigations with the scanning micropipet contact method (SMCM) which also indicated that the basal plane of HOPG was active towards the electrochemistry of iron complexes, including Fe(CN)$_6^{4-/3-}$, provided that measurements were made rapidly on freshly cleaved surfaces. A similar conclusion was reached for positively charged redox-active complexes, including Ru(NH$_3$)$_6^{3+/2+}$, by slowing down diffusion to the HOPG surface using a Nafion film. Frederix et al. and Demaille et al. also recently used different variants of scanning
electrochemical microscopy-atomic force microscopy (SECM-AFM)²³ to show that the HOPG basal surface was highly electrochemically active, although they also noted sometimes that step edges showed slightly enhanced activity. Notably, Frederix found that the kinetics for Ru(NH₃)₆³+/²⁺ were just as facile on the basal surface of HOPG as on template-stripped Au and Pt, and up to 2 orders of magnitude faster than measured in early CV studies.⁸c It was, however, observed that the ET kinetics at the basal surface depreciated over extended time.

To summarize: there are significant differences between the results obtained from microscale and nanoscale electrochemical measurements, on the one hand, and macroscale investigations, on the other hand. Moreover, at the macroscale, significant differences are evident in electrochemical behavior of apparently similar HOPG.⁷g,⁸f,⁸h,²⁰,²⁴ Further surprising is that studies purporting to show that the basal surface of HOPG supports only sluggish or no ET,⁷g,⁸f,⁸h,²⁰,²⁴ have been obtained on HOPG with very different surface quality (vide infra), and might have been expected to show contrasting behavior within the framework of a defect-driven activity model. Given the importance of HOPG as an electrode material, as highlighted herein, and its recent prominence as a comparator for graphene studies,¹a,¹⁵,²⁵ the studies in this paper aim to resolve and explain the issues highlighted. Our investigations have been carried out intermittently for a period of more than 6 years, on more than 25 HOPG samples, with cleavage of the surface and voltammetry carried out independently by 4 different people. We have considered ambient conditions, since these have been used in all previous electrochemical studies. Initially, we focused on the oxidation of Fe(CN)₆⁴⁻ (CV measurements on > 300 freshly cleaved surfaces), as most previous studies have been carried out with this electrode reaction, but included further studies of Ru(NH)₃⁵⁻ reduction (measurements on > 100 freshly cleaved surfaces), given the discrepancies in ET kinetics alluded to above.³c,⁶b,²⁵ We have examined 4 commercially available HOPG samples: ZYA; ZYH; SPI-1; and SPI-2 (all from SPI supplies, Aztech Trading, UK), the first 3 of which
have been employed in previous electrochemical studies.\textsuperscript{7g,8f,8h,20,24} We were also able to study high quality unclassified HOPG (kindly donated by Prof. R L. McCreery, University of Alberta, Canada, and originally sourced from Dr. A. Moore, Advanced Ceramics, formerly Union Carbide).

We show unequivocally that freshly cleaved pristine HOPG is much more electrochemically active than previously considered; however, the HOPG basal surface is shown to readily passivate in a number of ways. A particularly important observation is that the $\text{Fe(CN)}_6^{4-/3-}$ couple blocks and modifies the surface of HOPG during voltammetry, making this couple unsuitable for ‘validation experiments’,\textsuperscript{3,19,20} and for the assessment of electrode kinetics.\textsuperscript{8f,8h} We see consistent behavior at both the macroscale and nanoscale, and our studies provide a self-consistent and new view of HOPG electrochemistry, with significant implications for studying and understanding electrochemistry at related sp\textsuperscript{2} materials.

\textbf{EXPERIMENTAL}

\textit{Materials and solutions.} All chemicals were used as received. Aqueous solutions were prepared using high purity water (Milli-Q, Millipore) with a resistivity of \textit{ca.} 18.2 M$\Omega$ cm at 25°C. For voltammetry, solutions typically contained either 1 mM potassium ferrocyanide trihydrate ($\text{K}_4\text{Fe(CN)}_6\cdot3\text{H}_2\text{O}$; 99.99%, Sigma-Aldrich or 99%, Fisher Scientific) in either 0.1 M or 1 M potassium chloride (KCl) (Fisher Scientific, analytical grade) as supporting electrolyte, or 1 mM hexaamineruthenium(III) chloride ($\text{Ru(NH}_3\text{)_6Cl}_3$) (99.00% purity, Strem Chemicals) in either 0.5 M or 1 M KCl. However, some $\text{Fe(CN)}_6^{4-}$ oxidation experiments considered concentrations up to 10 mM and some control experiments were carried out with 0.1 M phosphate buffer (pH 7.2). For silver electrodeposition on HOPG, solutions contained 1 mM silver nitrate ($\text{AgNO}_3$) (AnalR) in 1 M potassium nitrate
(KNO₃; Fisher Scientific). All solutions were freshly prepared on the day of the experiments and stored in the dark when not in use. Measurements were made at ambient temperature (typically 22 ± 2° C) in air-conditioned rooms.

Four different grades of commercially available HOPG were employed: SPI-1, SPI-2, ZYA and ZYH, all from SPI supplies (Aztech Trading, UK, http://www.2spi.com). SPI-1 and SPI-2 are SPI brand samples, ZYA and ZYH are GE Advanced Ceramics brand samples. We also had access to a high quality, but ungraded, HOPG sample, originating from Dr. A. Moore, Union Carbide (now GE Advanced Ceramics), which was kindly provided by Prof. R. L. McCreery (University of Alberta, Canada). Hereafter, we refer to this as HOPG (AM). Table 1 contains key information on the properties and topography of these materials. Note, that as discussed below, the 4 commercial samples were cleaved with scotch tape to reveal a fresh surface for study, while HOPG (AM) was subjected to mechanical cleavage.

**Electrical contact to HOPG.** The samples were electrically contacted using one of two different supports: either (i) a printed circuit board (PCB), with an underlying electrical contact; or (ii) a silicon wafer, which was coated with a thermally evaporated layer of chromium (10 nm) followed by a layer of gold (100 nm) to create an electrical contact. With the PCB board, HOPG was adhered onto a square section using double sided adhesive tape designed for securing samples for AFM. Silver paint (Electrodag, Agar Scientific) was gently applied to the edge of the HOPG and the PCB to make an electrical connection. Finally, tinned copper wire was soldered to the PCB in order to make an external electrical contact. In the case of the silicon wafer, HOPG was adhered onto the gold layer using Acheson Electrodag (1415M) (Agar Scientific). An external electrical contact was created by lowering a metal pin onto the gold surface using a micro-positioner. This method also enabled samples to be secured for AFM and conducting AFM (C-AFM); see below.
Macroscale electrochemistry. CV and chronoamperometry (CA) measurements were carried out in a three-electrode configuration using a potentiostat (CH Instruments Model 750A, Austin, TX). A silver/silver chloride (Ag/AgCl) wire in KCl (0.1 M or 1 M as specified) served as the reference electrode. All potentials are quoted against the reference electrode employed (vide infra). The reference electrode was used in conjunction with a Pt gauze auxiliary electrode. For time effect studies the reference electrode was a Ag/AgCl wire placed inside a capillary which was fitted with an agar plug and filled with 1 M KCl. Capacitance measurements (Table 1) were made by simple CV measurements in 1 M KCl supporting electrolyte, as outlined in Supporting Information, section S1.

Cells for voltammetry on HOPG. One of the issues for voltammetric measurements at basal surface HOPG is how to present the material in an electrochemical cell, so that only the basal surface is exposed and there is no strain or distortion of the sample. HOPG is rather unusual in that it cannot readily be encapsulated for study, nor can it be cycled to extreme potentials for cleaning without disrupting the surface and promoting ion intercalation. For the studies reported herein, voltammetry was performed on freshly cleaved HOPG surfaces initially using a droplet arrangement. This avoided any possible mechanical strain on the HOPG surface. However, this arrangement was eventually superseded by a small Teflon cell as no difference was seen in voltammetric behavior with the two arrangements, and the Teflon cell was extremely useful for long time tests where more extensive solution evaporation might otherwise have been problematic. It was also essential for measurements where the area of HOPG exposed to solution needed to be known with high precision (e.g. for capacitance measurements), as the cell resulted in a well-defined disk electrode of HOPG of 3 mm diameter. These cells allowed measurements within 1 min of sample cleavage. We also reproduced a reported cell design in which HOPG was secured with pressure applied to an ‘O’- ring, but found the response to be sensitive to the amount of pressure applied, with the
voltammetry becoming distorted when the sample was increasingly compressed. Full details of the droplet and Teflon cells are given in Supporting Information, section S2. Unless otherwise stated, measurements reported herein generally refer to the Teflon cell arrangement.

The cells utilized had relatively small volume to working electrode area ratios and it was important to assess the extent of any changes in solution composition (including pH) due to electrolysis at the working and auxiliary electrodes. Experiments with pH 7.2 buffered solutions showed similar trends to the experiments reported herein without buffer (see Supporting Information, section S3), indicating that any possible change in solution pH was not an issue for the experiments reported. Furthermore, the change in solution composition was negligible on the timescale and extent of the measurements (vide infra). Finally, we also carried out some measurements on freshly cleaved surfaces with a capillary cell, using a glass capillary ca. 50 µm diameter. In this arrangement the diffusion layer at the working electrode is significantly smaller (by several orders of magnitude) than the height of solution in the capillary so that compositional changes are negligible. We observed similar behavior to that reported herein with the other cell arrangements.

**Scanning Electrochemical Cell microscopy (SECCM).** High resolution electrochemical imaging was performed on mechanically cleaved HOPG (AM) as described in detail elsewhere. We provide salient details here. A tapered dual-channel glass pipet, with an opening of ca. 350 nm (measured accurately with field-emission scanning electron microscopy, FE-SEM, vide infra), was filled with 2 mM Ru(NH$_3$)$_6^{3+}$ salt (0.1M KCl) and two Ag/AgCl quasi-reference counter electrodes (QRCEs) (one in each channel). The SECCM instrument comprised of a high-dynamic z-piezoelectric positioner (P-753.3CD LISA, Physik Instrumente), on which the pipet was mounted and a xy-piezoelectric stage (P-622.2CL PIHera, Physik Instrumente) for sample mounting. Contact between the liquid
meniscus at the end of the pipet and the HOPG surface produced a positionable and moveable nano-electrochemical cell. The pipet itself never touched the sample.

A potential bias applied between the two QRCEs resulted in a conductance current across the meniscus. An oscillation (20 nm peak amplitude, 233.3 Hz herein) imposed on the pipet using the z-piezoelectric positioner produced an alternating current (AC) component of the conductance current at the same frequency due to the periodic deformation of the liquid meniscus contact.\textsuperscript{30-31} This AC was used as a set-point during scanning so that the tip traced the surface at a constant separation (\textit{vida infra}). The SECCM tip was typically scanned over a 5 µm × 10 µm area of HOPG (AM) at a speed of 0.3 µm s\textsuperscript{-1}, scanning 3 lines per µm and recording a data point every 30.1 ms. This resulted in the acquisition of \textit{ca.} 1100 points per line and over 16000 individual measurements in an image. During experiments, the current at the substrate was recorded simultaneously with the \textit{xy} and \textit{z} position of the pipet and the conductance current (both DC and AC components). Data acquisition was achieved using an FPGA card (PCIe-7852R) with a LabVIEW 9.0 interface. The contact diameter of the meniscus and the substrate was determined in a previous study to be in the range 220-320 nm,\textsuperscript{1d} consistent with a growing body of work which indicates that the meniscus contact is of the order of the diameter of the pipet terminus.\textsuperscript{1d,31-32}

\textit{HOPG cleaving.} Three procedures were used to reveal a pristine freshly cleaved surface as outlined in full in Supporting Information, section S2. These involved: (i) the use of scotch tape to peel back a layer of HOPG and reveal a fresh surface; (ii) a mechanical cleavage procedure applied parallel to the HOPG surface; and (iii) a mechanical cleavage procedure, as carried out previously,\textsuperscript{8d,19} in which a razor blade was used to apply gentle pressure perpendicular to the basal plane, allowing a fresh piece to spontaneously delaminate. The latter was used exclusively for HOPG (AM).
For all methods, the cleaved surface was only used to run an experiment if it appeared ‘shiny’ to the eye (indicating lower step density) and was devoid of any visible macroscopic defects. Surfaces were routinely found to have a relatively low density of steps and low capacitance values, although there was some variation (vide infra). For each HOPG sample, where scotch tape was used, the direction of cleaving was maintained in order to avoid deformation of the surface. If the tape used to remove the outermost layers of the HOPG was not completely covered with HOPG, the procedure was repeated to ensure that no area of the surface was contaminated by adhesive from the tape. The scotch tape method was used most, as this has been used routinely by others.1e-h,5a,8a-g,10a,33

**AFM imaging.** AFM images of HOPG topography were recorded in air, using a Bruker Nano Multimode V AFM with Nanoscope V controller, in tapping mode (TM). HOPG step density, extracted from these images, is defined as the length of step edges per unit area (Table 1).12h

In-situ AFM images were obtained in electrolyte solution, with electrochemical control of the HOPG working electrode (CH Instruments model 750A or 800B potentiostat, Austin, Texas). TM-AFM images were recorded using an Environmental™ AFM (‘Enviroscope’, Bruker) with Nanoscope IV controller. The PCB-supported HOPG sample was adhered to an Enviroscope fluid cell using adhesive tape. The cell was filled with ca. 4.5 mL of a solution containing either 1 mM Fe(CN)$_6^{4-}$ salt (99.99%) in 1 M KCl, or 1 mM Ru(NH$_3$)$_6^{3+}$ salt in 0.5 M KCl. The PCB and sides of the HOPG were isolated from solution using a mix of 1:1 super glue and nail varnish. An Ag/AgCl wire served as the reference electrode (in the KCl electrolyte) and a Pt gauze was again used as the auxiliary electrode. Measurements were made with and without nitrogen flow to deaerate the solution with similar results.
Conducting (C-) AFM. C-AFM images of HOPG were obtained using a Veeco Multimode V AFM with a conducting module and Nanoscope V controller. In imaging mode, a bias of 20 mV was typically applied to a Pt–Ir coated Si probe (SCM-PIC, Bruker, quoted nominal radius of curvature ~20 nm) using the controller, with a current-limiting resistor of 1 MΩ in series with the grounded sample; the current output was detected by the controller. Experiments were also made where the tip was held stationary in an area of interest and conductance current-voltage (i-V) curves recorded. C-AFM was carried out either as soon as possible on freshly cleaved HOPG or as a function of time in air after cleaving (vide infra). After measurements, the integrity of all conducting tips was checked by replacing the sample with a new piece of freshly cleaved HOPG surface.

FE-SEM. A Zeiss SUPRA 55 VP field emission SEM with an in-lens detector was used to obtain images of HOPG.

RESULTS AND DISCUSSION

HOPG surface topography and step density

In order to understand the relationship between the voltammetric behavior of HOPG and surface structure it was important to fully characterize sample topography, particularly since the overwhelming majority of all previous voltammetric studies (see Introduction) have suggested that HOPG electroactivity is dominated, or controlled entirely, by step edges (edge planes) with the basal plane providing little or no contribution. Given its use as a flat substrate for imaging nanostructures and biomaterials,34 there are many AFM images of HOPG in the literature, but only a few studies21,20,19 have examined HOPG surfaces of different grades in any detail. Here, we investigated the surface topography of four major types of commercially available HOPG and HOPG (AM) in more detail than in any previous study to obtain clear bounds on the step density, which is essential to examine the validity (or
otherwise) of the step-active models.\textsuperscript{1c,4a,6b-d,32} Typical TM-AFM images are shown in Figure 1 and a summary of the data obtained is detailed in Table 1.

Figure 1 and Table 1 show clearly that mechanically cleaved HOPG (AM), closely followed by scotch tape cleaved ZYA grade HOPG, provide by far the most superior surfaces in terms of low step density. The other grades of HOPG show increasing step densities in the order ZYH, SPI-1 and SPI-2. Notably, SPI-1 grade, which has been used extensively for CV measurements,\textsuperscript{1c,4a,6b-d,32} shows a much higher step density than ZYA grade HOPG, even though ZYA and SPI-1 HOPG exhibit a similar mosaic spread. Surprisingly, although ZYH grade appeared to be roughest ‘to the eye’, the cleaved surface was found to have a reasonably low step density.

Given that the layer separation in HOPG is 0.335 nm,\textsuperscript{19,23} the AFM images were used to deduce step heights in terms of the number of graphite layers, as reported in Supporting Information, section S4. This analysis shows that most grades of HOPG (except ZYH and SPI-2) exhibit mainly monolayer and bilayer steps. Using the AFM images, we also calculated the fraction of the basal surface occupied by edge plane-like sites. These data are summarized in Table 1. From 69 images across 5 different grades of HOPG, one can see that the average step edge coverage varies significantly across the different grades, and also that within a grade, the range (from image to image on a particular surface) can vary by an order of magnitude. Thus, while the HOPG samples used herein provide a set of basal surfaces with different edge plane densities to test the premise that edge planes alone are responsible for the electroactivity of HOPG, our detailed analysis immediately raises questions about the validity of the step-edge active model for two significant reasons. First, previous work\textsuperscript{8a-e,20} - highlighted in the Introduction - has found that the standard rate constants of the Fe(CN)$_6^{4-/3-}$ couple, spans a factor of $ca. 10^5$ - $10^8$, yet step densities\textsuperscript{5h,19-21} including herein across 5 grades of HOPG, only span a maximum range of $10^2$. Second, while studies of different
grades of HOPG in one laboratory apparently show different ET kinetics,\textsuperscript{8d,21} investigations of different HOPG grades (evidently of widely variable quality based on the data herein) in different laboratories show similar slow ET kinetics. This appears contradictory for a step-edge model of HOPG activity.

For the commercial samples, cleaved by scotch tape, it was found that as a particular (new) HOPG sample was cleaved, the step density and step heights tended, very gradually, to become larger. This was consistent with technical information which recommends that the last 1 mm of a sample (i.e. half the initial sample) is discarded, since it comprises of the ‘base layer’ in which the mosaic spread is much higher than the ‘top working layer’.\textsuperscript{36} We followed this advice, for the electrochemical measurements reported.

The AFM analysis of surface quality was supported by capacitance measurements of SPI-1, ZYA and HOPG (AM) (see Supporting Information, section S1). ZYA yielded a capacitance value of $2.0 \pm 0.3 \ \mu \text{F cm}^{-2}$ (ranging between 1.7 to 2.8 \mu F cm$^{-2}$) consistent with the measurements of McCreery \textit{et al.} on this material.\textsuperscript{8d,21} Moreover, the lower capacitance values measured on ZYA grade HOPG are in agreement with the lowest reported for low defect HOPG in early work ($1.9 \ \mu \text{F cm}^{-2}$)\textsuperscript{8b} for which very large $\Delta E_p$ ($>700 \ \text{mV at 0.2 V s}^{-1}$) was seen for Fe(CN)$_6$$^{4-/3-}$. On the other hand, SPI-1 HOPG showed a slightly higher mean value and more variation, \textit{i.e.} $2.9 \pm 1.2 \ \mu \text{F cm}^{-2}$, but this is still a reasonably low value in the context of some values reported.\textsuperscript{8b,8e,37} For example, these values are far superior (lower) compared to those of ZYH grade HOPG recently reported by Bond and co-workers,\textsuperscript{8i} which varied between 3.4 to 7.1 \mu F cm$^{-2}$ (suggesting surfaces with more defects).\textsuperscript{8b,21} Yet, very large $\Delta E_p$ (slow kinetics) were still obtained for Fe(CN)$_6$$^{4-/3-}$ CVs in that work. We can thus be confident that we are working with samples of low step (and defect) density; at least as good as the best reported (for scotch tape cleaved material), and in many cases better.

Mechanically cleaved HOPG (AM) provided the lowest capacitance values ($0.7 \ \mu \text{F cm}^{-2}$) –
which essentially matched the very lowest ever reported for HOPG \(^{7d}\) - but also occasionally much larger values (7.4 \(\mu\text{F cm}^{-2}\)) were seen, leading to an average of 2.4 \(\pm 1.5 \mu\text{F cm}^{-2}\) (1 \(\sigma\)). This is again consistent with the wide range of values also observed by McCreery for HOPG (AM), where values between 0.6 and 6.5 \(\mu\text{F cm}^{-2}\) were reported.\(^{7d}\)

FE-SEM was employed to visualize further the step density on ZYA and SPI-1 grade HOPG over much wider areas, since these were used for most voltammetric studies: see Supporting Information, section S5. This analysis also confirmed that the step density was much lower on ZYA grade HOPG than SPI-1 grade.

**CV characteristics**

*Voltammetry on freshly cleaved surfaces.* We first consider CV measurements as a function of scan rate for SPI-1 and ZYA grade HOPG. For the plots shown in Figure 2, each CV was run on a freshly cleaved surface. For Figure 2(a) and (b), 1 mM Fe(CN)\(_6^{4/-3}\) (purity 99.99\%) in 1 M aqueous KCl was used. Similar data were obtained with 99\% purity Fe(CN)\(_6^{4/-3}\). The data shown are entirely representative of measurements carried out on > 300 freshly cleaved surfaces with the Fe(CN)\(_6^{4/-3}\) couple, independently by 4 different people. These measurements show near reversible behavior of the Fe(CN)\(_6^{4/-3}\) couple, for which \(\Delta E_p\) would be *ca.* 59 mV\(^{38}\) (Figure 2(aii) and 2(bii)). Although, in principle, one could attempt to analyze the CVs to obtain kinetic information, the \(\Delta E_p\) values are too close to the reversible limit for this to be meaningful. Furthermore, as shown below, the HOPG surface and the Fe(CN)\(_6^{4/-3}\) couple is complicated by time-dependent heterogeneous surface effects, making a kinetic analysis - that would assume a uniform surface and simple electrochemical process - less than ideal. Evidently, the \(\Delta E_p\) values are very similar for both types of HOPG despite the very large difference in characteristic step spacing and step coverage (Table 1). The data in Figure 2(aii) and (bii) also clearly show that the (forward) peak current is linear with the
square root of scan rate and yielded a diffusion coefficient of $7.3 \pm 0.3 \times 10^{-6}$ cm$^2$ s$^{-1}$ for Fe(CN)$_6^{4-}$, which is in agreement with literature.$^{39}$ The data is in sharp contrast with that reported (vide supra) in the past, where values as high as 1.5 V have been observed on samples with low defect density,$^{1g,8c,d,8f,17}$ but smaller values have also been reported, ranging from $\sim 350$ mV$^{9c}$ to $58$ mV$^{8c}$ (indicating essentially reversible behavior). In the past, surfaces that exhibited reversible behavior, were discarded as being too defective without further characterization to confirm surface quality and cleaved again.$^{8b,c}$ Our analysis suggests this is an incorrect interpretation of the voltammetric characteristics. As outlined briefly in Supporting Information, section S1, CV measurements on 20 freshly mechanically cleaved surfaces of HOPG (AM), half of which had capacitance measurements run first, also yielded responses that were close to reversible.

Figure 2 (c) shows the CV behavior and analysis of a freshly cleaved HOPG electrode (SPI-1 grade) for the reduction of 1 mM Ru(NH$_3$)$_6^{3+}$ in 1 M aqueous KCl, over the scan rate range $0.01$ V s$^{-1}$ to $1$ V s$^{-1}$. The redox process is again close to reversible and the diffusion coefficient for Ru(NH$_3$)$_6^{3+}$ is calculated as $8.7 \pm 0.3 \times 10^{-6}$ cm$^2$ s$^{-1}$, which is in agreement with literature.$^{40}$ The data, again, contrasts markedly with previous studies where large $\Delta E_p$ has been observed for the Ru(NH$_3$)$_6^{3+/2+}$ couple $\sim 200$ mV.$^{8c,8e,8i}$ Reversible behavior has been reported before$^{8g}$ but it was still concluded that the basal surface was totally$^{9c}$ or largely inert.$^{1c,4b}$

**Time-dependent effects.** Due to the contrast between the CV behavior seen herein and earlier work and also in light of microscale and nanoscale measurements reported recently,$^{1d,}$ we investigated time-dependent effects on the macroscale to ascertain any possible complications associated with voltammetry at HOPG. We first report time effects where CVs were typically recorded at $0.1$ V s$^{-1}$ every 5 minutes in the same solution for up to two hours. These studies were carried out with commercially available HOPG cleaved by scotch tape, as
this is the cleavage procedure used by researchers in the field in all recent studies\textsuperscript{7g,8f,8h,24} and many early studies.\textsuperscript{8a,b,41} Figure 3 shows data for 1 mM Fe(CN)$_6^{4-}$ (purity 99.99\%) in 1 M aqueous KCl on initially freshly cleaved HOPG: (a) ZYA; (b) SPI-1; (c) ZYH; (d) SPI-2. For all four grades, the $\Delta E_p$ value was seen to increase monotonically, with a dramatic change in wave shape and decrease in the magnitude of the current. This behavior is indicative of a systematic diminution in the effective rate of ET as the electrode undergoes repetitive CV. Notably, there is very little difference in the behavior of any of the grades of HOPG even though they have very different step quality (see Table 1). By comparison, for the reduction of 1 mM Ru(NH$_3$)$_6^{3+}$ in 0.5 M KCl (0.1 V s$^{-1}$) at freshly cleaved HOPG (SPI-1 grade), recorded in the same manner, as a function of time, only a small systematic change in the $\Delta E_p$ was seen, which ranged between $\sim$64 mV (first scan) to 77 mV (last scan). The data are given in Supporting Information, section S6. We discuss the origins of these effects and the differences in the two systems in the next sections.

An important consideration for these measurements is the possibility that the composition in the cell changes, due to the finite volume, and that this impacts the subsequent voltammetric response. For a typical sweep rate of 0.1 V s$^{-1}$, as used above, and in the remaining studies reported herein, the charge passed in the forward wave for Fe(CN)$_6^{4-}$ oxidation was typically $4 \times 10^{-6}$ C, representing $\sim$0.05 % of the total redox active material in the cell. Furthermore, in the reverse scan most of the electrogenerated Fe(CN)$_6^{3-}$ is converted back to Fe(CN)$_6^{4-}$. Thus, even though a small volume is employed, voltammetry has negligible effect on the bulk solution composition.

Studies at a range of concentrations are valuable as a means of probing surface adsorption and passivation effects. Yet, to our surprise, previous studies of redox processes at HOPG (highlighted in the Introduction) were typically carried out at just one concentration (1 mM). We found that the time-dependent CV response for Fe(CN)$_6^{4+/3-}$ showed a strong
concentration effect. Figure 4 shows a plot of $\Delta E_p$ against cycle number (5 minutes between scans) for concentrations of Fe(CN)$_6^{4-/3-}$ between 1 and 10 mM in 1 M KCl. Increasing the concentration of the redox species (and hence flux to the electrode surface) evidently leads to more rapid and more extensive passivation of the electrode surface with a tendency towards a limiting $\Delta E_p$ value of ca. 500 mV on this time scale. The concentration dependence is a clear indication that the observed passivation of the HOPG electrode is due to the electrolysis of the Fe(CN)$_6^{4-/3-}$ couple.

To determine whether the surface passivation could involve just the solution (without voltammetry), experiments were carried out where the solution (1 mM Fe(CN)$_6^{4+}$ (99.99%) in 1 M aqueous KCl), was left for: 0 mins (black); 1 hr (red) and 3 hrs (green) (at open circuit) on freshly cleaved HOPG before running a CV at 0.1 V s$^{-1}$. Typical data obtained on SPI-1 HOPG are shown in Figure 5(a). It can be seen that the $\Delta E_p$ value increases significantly with the time of HOPG surface exposure to solution. This is again evidence of a significant decrease in the effective ET kinetics. Thus, although the oxidation of Fe(CN)$_6^{4+}$ and subsequent reduction of Fe(CN)$_6^{3-}$ ‘passivates’ the HOPG surface, so does simply leaving the Fe(CN)$_6^{4+}$ solution in contact with the surface.

It has been reported that for both HOPG$^{3c}$ and a related material, basal plane pyrolytic graphite (BPPG),$^{4b}$ simply leaving the surface in air for short periods of time, just a few minutes, resulted in an increase in the $\Delta E_p$ value for Fe(CN)$_6^{4-/3-}$. As evident from Figure 5(b), we also saw a very similar deterioration in the CV response at HOPG for 1 mM Fe(CN)$_6^{4+}$ in 1 M KCl (0.1 V s$^{-1}$) by comparing: immediately after cleaving (black); 1 hr wait time before adding the solution (red) and 3 hr wait time before adding the solution (green). Interestingly, when the same procedures were carried out for 1 mM Ru(NH$_3$)$_6^{3+}$ in 0.5 M KCl, no significant change in the $\Delta E_p$ value was observed; Figure 5(c) and 5(d).
Further data for ZYA grade HOPG, Figure 6, show the effect of cleaving HOPG and leaving the surface in air for 24 hours before running CV measurements of: (a) 1 mM Fe(CN)$_6^{4-}$ in 1 M KCl at 0.1 V s$^{-1}$; and (b) 1 mM Ru(NH$_3$)$_6^{3+}$ in 0.5 M KCl. Voltammetry for Fe(CN)$_6^{4+/3-}$ is now very irreversible ($\Delta E_p > 1$ V), and for Ru(NH$_3$)$_6^{3+/2+}$ the behavior is affected ($\Delta E_p \sim 115$ mV) but much less.

We consider the origin of these various effects in the next section. Importantly, all of these macroscale observations are entirely consistent with our recent SECCM$^{1d}$ and SMCM studies.$^{10c}$ During SECCM imaging with Fe(CN)$_6^{4-/3-}$, on ZYA HOPG, the response was found to deteriorate during the course of a single scan (duration ~ 30 min), immediately after cleaving the HOPG surface, but for Ru(NH$_3$)$_6^{3+/2+}$ the response was more consistent, with only a small deterioration over time.

The passivation of HOPG by Fe(CN)$_6^{4-/3-}$ voltammetry was found to not only affect the exposed surface but also occasionally the sub-surface, most likely via penetration at step edges, as found for other anions.$^{42}$ This is illustrated by Figure 6(c), which shows the CV of freshly prepared HOPG (SPI-1 grade) with 1 mM Fe(CN)$_6^{4-}$ in 1 M KCl, after the sample had been fully immersed in solution and cycled extensively, and then cleaved gently once. The CV shows a very irreversible response ($\Delta E_p$ of ~1.2 V).

**HOPG surface effects**

Blocking of the electrode surface would be a plausible reason for the change in ET kinetics for Fe(CN)$_6^{4-/3-}$ with time reported above, and we thus investigated whether such effects occurred via *in-situ* TM-AFM experiments. Images of HOPG electrode surfaces (SPI-1 grade) were recorded in solution, before and after the electrode was cycled up to 20 times at 5 minute intervals at 0.1 V s$^{-1}$ between 0.0 V and 0.6 V, in a solution of 1 mM Fe(CN)$_6^{4-}$ (purity 99.99%) in 1 M KCl. We chose this grade of HOPG because of its use for prominent
voltammetric studies,¹c,⁵a,b,²⁹ and also because the relatively high density of steps (Table 1) allows us to compare step-edge vs. basal regions of the cleaved HOPG surface.

TM-AFM provides simultaneous topographical (height) and phase images. The AFM phase image informs on any changes in energy dissipation during the tip-sample interaction due to changes in topography, tip-sample molecular interactions and deformation at the tip-sample contact, among other factors.⁴³ Although difficult to interpret quantitatively, the phase angle is sensitive to changes in the local material properties and can thus provide enhanced contrast. This aspect of TM-AFM is evident in data obtained for HOPG after 1 hour in solution (before any voltammetry), where the topography image appears to show a relatively clean surface (Figure 7(ai)), while the phase image highlights considerable surface heterogeneity, notably around step edges but also on the basal terrace. This morphological change of the surface links directly to the slower kinetics seen after leaving Fe(CN)₆⁴⁻ solution in contact with the surface.

After potential cycling, the topography - recorded in the same area as for Figure 7(ai) - still appears to indicate a clean surface, but the corresponding phase image evidences further significant local changes in the surface at many locations, which could be indicative of adsorbed material. The images in Figure 7(b) in fact represent the cleanest surface observed of eight substrates that were potential cycled in separate AFM experiments. For example, Figure 7(c) shows other behavior, where - after potential cycling - adsorbed material can be seen as discrete topographical features of ca. 5-10 nm in height, which also give rise to significant contrast in the corresponding phase image. Note that during the recording of this image the tip is likely to have picked up material from the surface, as indicated by the sudden change in the phase image part of the way through the scan and the repetition of features in both the topography and phase image (“multiple tip imaging”). Since Figures 7(bii), (ci) and (cii) show evidence that material is deposited over the basal surface as
well as at the step edges, in agreement with the voltammetric data above, we deduce that blocking of the basal surface of HOPG leads (at least in part) to a diminution in electrode activity for the Fe(CN)$_6^{4/-3}$ couple.

Additional (control) in-situ TM-AFM studies were carried out using the same time procedure, but with 1 mM Ru(NH$_3$)$_6^{3+}$ in 0.5 M KCl, with the HOPG cycled between 0 V and -0.8 V, and with just supporting electrolyte (1M KCl), with the working electrode potential cycled between 0 V and 0.6 V. No changes in the topography or in the phase images were seen in either of these cases, even after cycling for up to 2 hours. Thus, it is clear that the observed deterioration in electrode kinetics for the Fe(CN)$_6^{4/-3}$ couple on HOPG is specific to this couple. High resolution imaging and spectroscopic studies$^{44}$ for other electrode materials has clearly shown that side-products are involved in the Fe(CN)$_6^{3/-4}$ voltammetric process, leading to the formation of insoluble Prussian Blue-like materials.$^{44a}$ It is entirely reasonable to assume that similar processes operate for Fe(CN)$_6^{4/-3}$ on HOPG.

We have shown for other carbon-based electrodes that maps of the local electroactivity of the surface correspond well to the local intrinsic conductivity of the electrode, as determined by C-AFM.$^{45}$ We thus assessed the local conductivity of HOPG, using C-AFM in air, focusing again on SPI-1 grade material, using the protocol outlined in the experimental section. Figures 8(a) and (b) show typical (i) height and (ii) conductivity images ($5 \times 5 \ \mu m$) recorded simultaneously, at 0.5 Hz, of (a) a freshly cleaved surface and (b) an initially freshly cleaved surface that was left in air for 24 hours before imaging. Note that slight “streaking” seen, also evident in previous C-AFM images of HOPG,$^{46}$ is likely due to variations in the tip to surface contact, as the tip scans the surface, but does not impact the capability to identify the general surface conductivity properties of HOPG.

It is evident that although the surface is conducting, the current varies from terrace to terrace. To provide further information on the local conductivity of the HOPG surface, C-
AFM (i-V) curves were recorded in distinct regions of the basal surface, which showed different current levels in the C-AFM map. Three such curves are shown in Figure 8(aiii), recorded in the vicinity of the terrace regions labeled 1 (black), 2 (red) and 3 (blue) in Figure 8(aii). In all cases the i-V curves recorded repeatedly in the same spot overlapped (n = 5). For these three different characteristic i-V curves, local resistance (R) values were extracted in the low bias region i.e. -100 mV to +100 mV yielding R = 1.3 MΩ (terrace 1), R = 1 MΩ (terrace 2) and R = 3.7 MΩ (terrace 3). Note that these values include the 1MΩ resistor placed in series in the experimental measurements to limit the current flowing and possible damage to the metal-coated tip.

Figure 8(b) shows that the conductivity of the surface, after 24 hrs exposure to the atmosphere, is dramatically altered compared to the freshly cleaved case (Figure 8(a)), with some domains essentially inert at the applied potential bias and others showing greatly reduced conductivity. By recording i-V curves in the vicinity of the 5 different terraces labeled in Figure 8(biii), R values were extracted in the region of low bias: R = 13 MΩ (terrace 1), R = 13 MΩ (terrace 2), R = 268 MΩ (terrace 3), R = 26 MΩ (terrace 4) and R = 267 MΩ (terrace 5), with a 1 MΩ resistor in series. These raw values are one to two orders of magnitude higher than the R values recorded on the freshly cleaved surface, and indicate a change in either tip-surface contact resistance or the local resistance of the HOPG surface layers of at least 3 orders of magnitude in some locations (taking into account the current-limiting resistor). The i-V curves all show a non-linear increase in the current at high bias.

The C-AFM data clearly show that long time exposure of HOPG to ambient conditions results in a significant increase in the local resistance of the surface compared to a freshly cleaved surface. In fact the deterioration in basal plane conductivity occurs on a fairly rapid time scale as shown in Supporting Information, section S7. It has been reported\textsuperscript{8g} that
polished and cleaved BPPG exposed to air for up to 2 hrs, resulted in increasing kinetic effects for Fe(CN)$_6^{4-/3-}$. This was attributed purely to the oxygenation of edge planes. Although we cannot rule this out or in, our data clearly indicate that gross changes in the conductivity of much of the exposed basal surface are most in the case of HOPG (and, by extension, to BPPG as well). It is well known that HOPG voltammetry is notoriously sensitive to deliberate treatment of the surface with organic impurities. Naturally, extended periods, under ambient conditions, enhances the chance of the surface becoming contaminated, which would result in a greater contact resistance and tunneling barrier between the C-AFM tip and the HOPG surface. Such a barrier layer would naturally also influence voltammetric behavior, and links convincingly to the electrochemical studies presented above. It is also possible that the top layer(s) of the HOPG could spontaneously delaminate leading to poor electrical contact. Evidently, the C-AFM studies highlight new issues connected with HOPG surface properties which may impact the analysis of earlier work, and need to be taken into account in the design and analysis of future studies of HOPG and mechanically exfoliated graphene.

**Nanoscale visualization of electrochemical activity with SECCM**

SECCM is a powerful imaging technique for the simultaneous study of topography, surface electroactivity and conductivity, where the meniscus at the end of a pipet is used as a positionable and moveable nanoelectrochemical cell once contacted with a electrode surface (Figure 9). The pipet tip was oscillated perpendicular to the substrate, giving rise to a modulated current, $I_{AC}$, and increase in the DC conductance current when the meniscus made contact with the surface. As described in the experimental section, and in full elsewhere, $I_{AC}$ is used as a set-point for imaging during which the surface electrochemical current, $I_{act}$, at an effective bias of $-(V_s + \frac{1}{2} V_{bias})$, with respect to the QRCEs in the pipet, is
recorded. This technique has recently been used to visualize electrochemistry at cleaved ZYA grade HOPG where the spatial contact was an order of magnitude smaller than the step spacing. This study showed conclusively that essentially uniform and fast electrochemical activity prevailed for the reduction of Ru(NH$_3$)$_6^{3+}$ at the basal surface of HOPG. As highlighted above (Figure 1 and Table 1), the step spacing on mechanically cleaved HOPG (AM) is even larger than scotch tape cleaved ZYA grade HOPG, and as this has been proposed as the key material and cleavage procedure we considered it worthwhile to map its local electrochemical activity. As there are major complications involved in using the Fe(CN)$_6^{4+/3-}$ couple, as evidenced in our previous imaging studies and the macroscopic measurements reported herein, we chose to focus on the Ru(NH$_3$)$_6^{3+/2+}$ couple.

Figure 10 shows SECCM maps of: (a) quasi-topography, (b) surface electrochemical activity and (c) conductance current recorded between the barrels of the SECCM tip obtained for the reduction of 1 mM Ru(NH$_3$)$_6^{3+}$ in 0.1 M KCl at a potential close to the reversible quarter-wave potential, as determined by SECCM voltammetry, on mechanically cleaved HOPG (AM). Parallel steps running across the surface with a basal region spanning up to 5 μm in length is clearly evident at the right hand side of the maps of quasi-topography (a) and SECCM conductance (c). Importantly, the surface activity (b) can be seen to be essentially constant at approximately 12.7 ± 1.0 pA (1 σ). For this tip, the mass transport limited current was ca. 60 pA and so the surface redox process measured is close to reversible across the basal surface of HOPG (AM). Based on the arguments advanced recently, we estimate a mass transfer coefficient ca. 0.25 cm s$^{-1}$, based on meniscus contact area approximating to the tip opening and the limiting current defined above, from which we put a (conservative) lower limit ca. 0.1 cm s$^{-1}$ on the standard rate constant for the Ru(NH$_3$)$_6^{3+/2+}$ couple.

As in our recent study of ZYA grade HOPG, a small increase in surface electrochemical current (Figure 10(b)) is observed at the step sites, but there is also an
increase in the conductance current between the barrels of the SECCM tip at the same locations (Figure 10(c)), likely due to a small disturbance in the meniscus as it passes over (hydrophilic) step edges. This effect is shown very clearly in the line scans of surface electrochemical current and corresponding conductance current in Figure 10(d). A representative AFM image of mechanically cleaved HOPG (AM) in an area close to the SECCM measurements, recorded after the SECCM measurements, shows that there are step separations greater than 5 μm in this region of the surface (Figure 10(e)) consistent with the SECCM measurements. Thus, the nanoscopic SECCM visualization studies on pristine, freshly-cleaved HOPG show that heterogeneous ET occurs readily at the basal surface, entirely consistent with the macroscopic measurements, but providing a clear view as to the origin of the electroactivity.

**CONCLUDING REMARKS**

We have reappraised classical voltammetry at the basal surface of HOPG, a material of intrinsic importance, but also one that is gaining increasing prominence as a ‘standard’ to which new sp² carbon materials, such as CNTs and graphene, are compared. Making extensive use of high resolution microscopy to understand the surface characteristics of HOPG, the studies reported herein provide a new and self-consistent view of the electroactivity, tying together macroscale, microscale and nanoscale measurements. Our results show unequivocally that the pristine HOPG surface, which has been variously described as supporting only sluggish ET behavior, or even as being completely inert, has, in fact, considerable ET activity.

The freshly cleaved basal surfaces of five different grades of HOPG, cleaved by scotch tape or a mechanical procedure, show essentially reversible voltammetry for both $\text{Fe(CN)}_6^{4+/3-}$ and $\text{Ru(NH}_3)_6^{3+/2+}$ on the CV timescale. The general quality and step edge
density of these surfaces has been fully characterized by AFM. For ZYA and SPI-1 material cleaved by scotch tape and HOPG (AM) cleaved mechanically, the quality of the surfaces has been further confirmed by capacitance measurements, as recommended in the early literature. These HOPG samples provide a range of step-edge densities on the basal surface and, in the context of ZYA grade and AM material, particularly low step-edge densities (among the lowest reported) and a basal surface of high quality. This range of surfaces has enabled the significance of steps edges, in the HOPG electrode response, to be explored and identified. The analysis of this wide range of materials is further important in light of a recent report\(^{51}\) of the inclusion of micron-sized Fe-type particles in ZY-materials, albeit with rather large (100 - 200 µm) lateral spacing, which is unlikely to impact electrochemistry. In contrast, SPI-materials do not show such inclusions.\(^{51}\)

Significantly, the new view of the macroscopic electrochemical response agrees entirely with recent direct microscale and nanoscale studies of basal surface HOPG,\(^{1d,10}\) and further SECCM studies reported herein. It is important to note that the basal surface itself will contain point (atom-scale) defects, which may have a higher local density of electronic states.\(^{52}\) Such sites may have different local ET activity to the basal terrace surface or indeed control it, but this has not, hitherto, been considered an issue needed to explain the voltammetric response of HOPG. Determining the significance, if any, of such sites would require the preparation and characterization of HOPG materials with different densities of point defects, which is non-trivial,\(^{51}\) and/or further improvement of nanoscale electrochemical imaging methods, which could eventually have sufficiently high resolution to address this issue directly.\(^{30,48c,53}\)

Our CV measurements on freshly cleaved surfaces conflict with many other high profile studies in the literature,\(^{5a,6a-c,8}\) which are frequently cited as evidence that the basal surfaces of sp\(^2\) carbon materials are essentially inert in terms of ET.\(^{1g,8,17,49a}\) Extensive studies
reported in this paper, exploring HOPG surface and time effects were aimed at rationalizing and explaining our data in the context of this past work. A significant finding is that Fe(CN)$_6^{4-}$ solution and voltammetry leads to the surface-adsorption of material which greatly impedes subsequent ET for the Fe(CN)$_6^{4/-3-}$ couple. Likewise, after cleaving, there are major time-dependent changes in the surface conductance properties of HOPG, probably by adsorbed impurities or other changes in the HOPG surface layer, which correlates with a measured deterioration in the Fe(CN)$_6^{4/-3-}$ voltammetric response.

On the other hand, the surface effects observed (blocking of the HOPG electrode and changes in the surface conductivity) have much less influence on Ru(NH$_3$)$_6^{3+/2+}$ voltammetry at the macroscale. Of course, time-dependent changes in surface activity may occur on the microscale and nanoscale and we plan to investigate the significance, if any, of such effects for Ru(NH$_3$)$_6^{3+/2+}$ in the future. In light of the work herein, it is unfortunate that Fe(CN)$_6^{4/-3-}$ voltammetry was selected as a means for ‘surface validation’$^{8a-e}$ of HOPG for the subsequent study of further redox couples whose ET kinetics may have been impaired, and that it has been used extensively as a redox probe to assess ET activity at the basal surface of HOPG.$^{1g,8f,g,9b,c,50a}$

The surface effects we have observed occur on a short time scale and become more prevalent over longer timescales (typically a few CVs, or a timescale of an hour or more). In some instances, the CV morphologies that result are then similar to some of those in the past literature. For example, the CVs for Fe(CN)$_6^{4/-3-}$ after extensive cycling (Figure 3) and after deploying a wait time of a few hours before cycling (Figure 5(a) and (c)) resemble those in refs 8g and 9c). Similarly, the very distorted voltammograms evident after leaving HOPG for a long period before running voltammetry (Figure 6(a)) and cleaving after extensively cycling (Figure 6(c)) resemble the morphology of those reported previously.$^{1g,8a,e,f,8h,i,17}$ Some of these past studies provide little information on the precise time frame of the measurements,
although they evidently aim to consider pristine surfaces.\textsuperscript{1g,8f,8h,i,17} The results herein thus potentially provide an explanation of this past work, particularly as we have worked with identical HOPG material from the same supplier, and cleaved in the same way. On the other hand, in the oldest body of past work measurements were made immediately after cleaving HOPG.\textsuperscript{8b,c} In view of this, it is difficult to explain the difference in initial CV behavior seen in our work and these past studies, but if impurity adsorption (and other surface effects) were responsible for the dramatic deterioration we have observed in HOPG surface conductivity, and concomitant changes in the Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} voltammetric response, one might reasonably expect different timescales for such processes in different laboratories/environments and, of course, in different eras. Alternative explanations for the discrepancy between the work of McCreery \textit{et al.} and the current work include possible differences in the HOPG samples (for example, point defects, as we mention above) or that the ‘validation’ method for identifying low defect surfaces was erroneous.

It is important to point out that the reversible (or fast ET) we report herein for Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} on freshly cleaved HOPG has been seen by others for HOPG.\textsuperscript{6c,47,49b} However, in light of the earlier recommendations about the Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} couple being diagnostic of surface quality,\textsuperscript{8a-e,35} it was assumed that in those studies\textsuperscript{6c,47,49b} the HOPG surfaces used must have been very defective, although no other corroboratory evidence was provided. Our studies clearly establish that the pristine basal surface of a wide range of HOPG (AM, ZYA, ZYH, SPI-1 and SPI-2) provides an active electrode material for ET, as evident from studies of both Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} and Ru(NH\textsubscript{3})\textsubscript{6}\textsuperscript{3+/2+}. Finally, this new view of the electroactivity of the HOPG basal surface – and the important issues concerning the use of Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} and the timescale of measurements, are expected to be valuable for rationalizing different viewpoints on other sp\textsuperscript{2} carbon materials. In particular, Fe(CN)\textsubscript{6}\textsuperscript{4-/3-} has been used in recent studies of the electrochemical properties of monolayer and multilayer graphene,\textsuperscript{1a,15b,25} and comparisons
have generally been made between graphene and HOPG.\textsuperscript{15b,25} It is evident from our studies that Fe(CN)\textsubscript{6}^{4/-3-} should be used with caution for such studies in the future, if at all. Moreover, electrochemical studies of exfoliated graphene, in particular, need careful control and identification of the measurement time after exfoliation.

**ACKNOWLEDGMENTS**

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**Supporting Information Available:** Additional details are provided on capacitance measurements, experimental procedures, step edge analysis using AFM and FE-SEM and C-AFM experiments. This material is available free of charge via the Internet at http://pubs.acs.org.
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<td>(N = 14)</td>
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<td>1.8%</td>
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<td>0.8%</td>
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<td>Size (mm)</td>
<td>12 × 12 × 2</td>
<td>10 × 10 × 2</td>
<td>12 × 12 × 2</td>
<td>10 × 10 × 2</td>
<td>varied</td>
</tr>
<tr>
<td>Capacitance (µF cm⁻²)††</td>
<td>2.0 ± 0.3</td>
<td>2.9 ± 1.2</td>
<td>-</td>
<td>-</td>
<td>2.4 ± 1.5</td>
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<tr>
<td>(range)</td>
<td>1.7 - 2.8</td>
<td>2.0 - 3.8</td>
<td>(N = 10)</td>
<td>(N = 10)</td>
<td>(range)</td>
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<td>(N = 10)</td>
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<td></td>
<td></td>
<td></td>
<td>0.7 – 7.4</td>
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<td>†From <a href="http://www.spi2.com">www.spi2.com</a>. The mosaic spread describes how ordered a sample is by providing the average angle of deviation of grains from the perpendicular axis.</td>
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<td>††Measured at 0.05 V vs. Ag/AgCl (1.0 M KCl).</td>
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<td>†††AM was mechanically cleaved and other samples were cleaved using scotch tape. For image analysis and capacitance measurements, N refers to the number of cleaved surfaces investigated. Errors are 1 standard deviation.</td>
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FIGURES

**Figure 1.** TM-AFM topography images of freshly cleaved HOPG: (a) ZYA, (b) SPI-1, (c) ZYH, (d) SPI-2 grades and (e) AM.

**Figure 2.** CVs at a range of scan rates for the oxidation of 1 mM $\text{Fe(CN)}_6^{4+}$ (99.99%) in 1 M KCl on (a) SPI-1 and (b) ZYA HOPG. (c) CVs for the reduction of 1 mM $\text{Ru(NH}_3)_6^{3+}$ in 0.5 M KCl on HOPG (SPI-1). In all figures labelled (i) the scan rates are as follows: 0.01, 0.03, 0.05, 0.07, 0.1, 0.2, 0.3, 0.4, 0.5, 0.6, 0.7, 0.8, 0.9, 1 V s$^{-1}$. The corresponding analyses of peak current ($i_p$) and peak-to-peak separation ($\Delta E_p$) as a function of (scan rate)$^{1/2}$ are shown in (ii). Each CV shown was run on a freshly cleaved surface.

**Figure 3.** Repeat CVs for the oxidation of 1 mM $\text{Fe(CN)}_6^{4+}$ (1 M KCl), run at 0.1 V s$^{-1}$ on (a) ZYA, (b) SPI-1, (c) ZYH, (d) SPI-2 HOPG. Each cycle was run at 5 minute intervals; total of 20 cycles in each case.

**Figure 4.** $\Delta E_p$ against CV cycle number for concentrations of 1 mM (■), 2 mM (▲), 5 mM (▲) and 10 mM (▼) $\text{Fe(CN)}_6^{4+}$ in 1 M KCl, run at 0.1 V s$^{-1}$ on SPI-1 grade HOPG.

**Figure 5.** CVs for the oxidation of 1 mM $\text{Fe(CN)}_6^{4+}$ in 0.1M KCl, at 0.1 V s$^{-1}$: (a) after leaving the solution in contact with the HOPG (SPI-1) for 0 minutes (black), 1 hour (red) and 3 hours (green); (b) after a freshly cleaved HOPG (SPI-1) surface was left for 0 minutes (black), 1 hour (red) and 3 hours (green). CVs for the reduction of 1 mM $\text{Ru(NH}_3)_6^{3+}$ in 0.5M KCl at 0.1 V s$^{-1}$: (c) after leaving the solution in contact with the HOPG for 0 minutes (black), 1 hour (red) and 3 hours (green); (d) after a freshly cleaved HOPG (SPI-1) surface was left for 0 minutes (black), 1 hour (red) and 3 hours (green). All CVs run on HOPG (SPI-1).

**Figure 6.** CVs (0.1 V s$^{-1}$) for (a) the oxidation of 1 mM $\text{Fe(CN)}_6^{4+}$ in 1M KCl and (b) the reduction of 1 mM $\text{Ru(NH}_3)_6^{3+}$ in 0.5 M KCl. Each CV was run after the surface of the HOPG (SPI-1) was cleaved and left in air for 24 hours. (c) CV for the oxidation of freshly
made 1 mM Fe(CN)$_6^{4-}$ in 1 M KCl when the sample had been in Fe(CN)$_6^{4-}$ solution and cycled between 0 to 0.8 V for over 2 hours then gently cleaved once to remove the minimum number of layers but ensuring that the entire surface had been cleaved.

**Figure 7.** *In-situ* TM-AFM height (i) and phase (ii) images taken on HOPG (SPI-1) during CV measurements run at 0.1 V s$^{-1}$ in 1 mM Fe(CN)$_6^{4-}$ (purity 99.99%) in 1 M aqueous KCl: (a) before the first CV was run; (b) in the same area as (a) after 20 cycles; and (c) a different sample to (a) and (b) after 20 cycles were run.

**Figure 8.** Simultaneously recorded height (i) and conductivity (ii) images ($5 \times 5 \mu$m) on HOPG (SPI-1) immediately after cleavage (a) and 24 hours after cleavage (b). (iii) C-AFM $i$-$V$ curves recorded in terrace locations 1, 2 and 3 marked on (aii) and terrace locations 1, 2, 3, 4 and 5 marked on b(ii).

**Figure 9.** Schematic of the set up for SECCM (see text for description).

**Figure 10.** SECCM maps of (a) quasi-topography, (b) surface electrochemical activity and (c) conductance current (DC component) recorded at the reversible ¼-wave potential for the reduction of 1 mM Ru(NH$_3$)$_6^{3+}$ at HOPG (AM) mechanically cleaved obtained with a ~350 nm pipet. (d) Example line section of surface electrochemical activity (green) and conductance current (blue) from marked region in (b) and (c). (e) AFM image representative of the surface.
Figure 1
Figure 2

(a) (i) SPI-1

(ii) Graph showing current vs. potential with scan rate.

(b) (i) ZYA

(ii) Graph showing current vs. potential with scan rate.

(c) (i) SPI-1

(ii) Graph showing current vs. potential with scan rate.
Figure 3

(a) ZYA  
(b) SPI-1

(c) ZYH  
(d) SPI-2

Current / μA

Potential vs Ag/AgCl (1 M KCl) / V
Figure 4
Figure 5

(a) Current vs Potential for 0.1 M KCl

(b) Current vs Potential for 0.1 M KCl

(c) Current vs Potential for 0.5 M KCl

(d) Current vs Potential for 0.5 M KCl
Figure 6

(a) Current / μA vs Potential vs Ag/AgCl (0.1 M KCl) / V

(b) Current / μA vs Potential vs Ag/AgCl (0.5 M KCl) / V

(c) Current / μA vs Potential vs Ag/AgCl (0.1 M KCl) / V
Figure 7
Figure 8
Figure 9
Figure 10
REFERENCES


(36) (a) www.ktechnano.com (accessed 31-05-2012); (b) www.ntmdt-tips.com (accessed 31-05-2012)


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